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SN74LVC1G79

SCES220U - APRIL 1999-REVISED APRIL 2017

SN74LVC1G79 Single Positive-Edge-Triggered D-Type Flip-Flop

1 Features

Texas

INSTRUMENTS

- Available in the Texas Instruments NanoFree[™] Package
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- Supports 5-V V_{CC} Operation
- Inputs Accept Voltages to 5.5 V
- Supports Down Translation to V_{CC}
- Max t_{pd} of 6 ns at 3.3 V and 50 pF load
- Low Power Consumption, 10-µA Max I_{CC}
- ±24-mA Output Drive at 3.3 V
- I_{off} supports Partial-Power-Down Mode and Back-Drive Protection

2 Applications

- Test and Measurement
- Enterprise Switching
- Telecom Infrastructure
- Personal Electronics
- White Goods

3 Description

The SN74LVC1G79 device is a single positive-edge-triggered D-type flip-flop that is designed for 1.65-V to 5.5-V V_{CC} operation.

When data at the data (D) input meets the setup time requirement, the data is transferred to the Q output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the level at the output.

NanoFree[™] package technology is a major breakthrough in IC packaging concepts, using the die as the package.

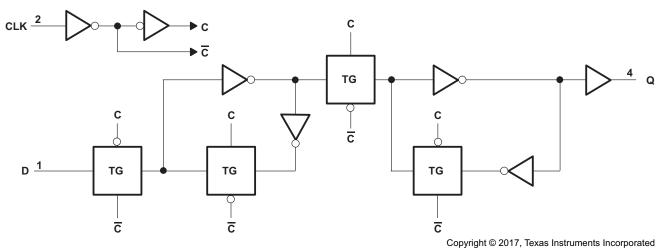
This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs when the device is powered down. This inhibits current backflow into the device which prevents damage to the device.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE | | | | | | | | |
|----------------|------------|-------------------|--|--|--|--|--|--|--|--|
| SN74LVC1G79DBV | SOT-23 (5) | 2.90 mm × 1.60 mm | | | | | | | | |
| SN74LVC1G79DCK | SC70 (5) | 2.00 mm × 1.25 mm | | | | | | | | |
| SN74LVC1G79DRL | SOT (5) | 1.60 mm × 1.20 mm | | | | | | | | |
| SN74LVC1G79YZP | DSBGA (5) | 1.14 mm × 0.91 mm | | | | | | | | |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Logic Diagram (Positive Logic)



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision T (December 2013) to Revision U

Page Added Device Information table, ESD Ratings table, Thermal Information table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section 1

Changes from Revision S (November 2007) to Revision T

| • | Updated document to new TI data sheet format | . 1 |
|---|--|-----|
| • | Removed Ordering Information table. | 1 |
| • | Updated I _{off} in Features. | 1 |
| • | Updated operating temperature range. | 5 |
| • | Added ESD warning. | 15 |

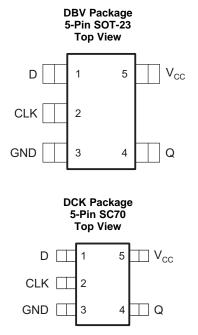
XAS STRUMENTS

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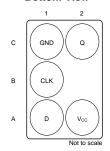
5 Pin Configuration and Functions



See mechanical drawings for dimensions.

DRL Package 5-Pin SOT Top View D 1 5 V_{CC} CLK 2 GND 3 4 Q

YZP Package 5-Pin DSBGA Bottom View



| | Pin Functions | | | | | | | | | | |
|-----------------|------------------|-----|-----|-------------------------------------|--|--|--|--|--|--|--|
| PIN | | | | | | | | | | | |
| NAME | DBV, DCK, DRL | YZP | I/O | DESCRIPTION | | | | | | | |
| D | 1 | A1 | I | Data input | | | | | | | |
| CLK | 2 | B1 | I | Positive-Edge-Triggered Clock input | | | | | | | |
| GND | 3 | C1 | _ | Ground | | | | | | | |
| Q | 4 | C2 | 0 | Non-inverted output | | | | | | | |
| V _{CC} | 5 | A2 | | Positive Supply | | | | | | | |

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | | | MIN | MAX | UNIT |
|------------------|---|---------------------|------|-----------------------|------|
| V _{CC} | Supply voltage | | -0.5 | 6.5 | V |
| VI | Input voltage ⁽²⁾ | | | 6.5 | V |
| Vo | Voltage range applied to any output in the high-impedance or power-off state ⁽²⁾ | | | 6.5 | V |
| Vo | Voltage range applied to any output in the high or low state ⁽²⁾⁽³⁾ | | | V _{CC} + 0.5 | V |
| I _{IK} | Input clamp current | V ₁ < 0 | | -50 | mA |
| I _{OK} | Output clamp current | V _O < 0 | | -50 | mA |
| I _O | Continuous output current | | | ±50 | mA |
| | Continuous current through V_{CC} or GND | | ±100 | mA | |
| T _{stg} | Storage temperature | Storage temperature | | | |
| TJ | Junction temperature | | | 150 | °C |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The value of V_{CC} is provided in the *Recommended Operating Conditions* table.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|----------------------------|--|-------|------|
| | | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±2000 | |
| V _(ESD) | Electrostatic discharge | Charged device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±1000 | V |
| | alcondigo | Machine Model (MM), A115-A | 200 | |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | | | MIN | MAX | UNIT | |
|-----------------------|------------------------------------|--|------------------------|------------------------|------|--|
| | Questions | Operating | 1.65 | 5.5 | V | |
| V _{CC} | Supply voltage | Data retention only | 1.5 | | V | |
| | | V _{CC} = 1.65 V to 1.95 V | 0.65 × V _{CC} | | | |
| V | $V_{\rm CC} = 2.3$ | V _{CC} = 2.3 V to 2.7 V | 1.7 | | V | |
| VIH | High-level input voltage | V _{CC} = 3 V to 3.6 V | 2 | | v | |
| | | V _{CC} = 4.5 V to 5.5 V | 0.7 × V _{CC} | | | |
| | | V _{CC} = 1.65 V to 1.95 V | | 0.35 × V _{CC} | | |
| V | | V _{CC} = 2.3 V to 2.7 V | | 0.7 | V | |
| VIL | Low-level input voltage | V _{CC} = 3 V to 3.6 V | | 0.8 | v | |
| | | V _{CC} = 4.5 V to 5.5 V | | $0.3 \times V_{CC}$ | | |
| VI | Input voltage | | 0 | 5.5 | V | |
| Vo | Output voltage | | 0 | V _{CC} | V | |
| - | | V _{CC} = 1.65 V | | -4 | | |
| | | V _{CC} = 2.3 V | | -8 | | |
| I _{OH} | High-level output current | | | -16 | mA | |
| | | $V_{CC} = 3 V$ | | -24 | | |
| | | V _{CC} = 4.5 V | | -32 | | |
| | | V _{CC} = 1.65 V | | 4 | | |
| | | V _{CC} = 2.3 V | | 8 | | |
| I _{OL} | Low-level output current | | | 16 | mA | |
| | | $V_{CC} = 3 V$ | | 24 | | |
| | | V _{CC} = 4.5 V | | 32 | | |
| | | V_{CC} = 1.8 V ± 0.15 V, 2.5 V ± 0.2 V | | 20 | | |
| $\Delta t / \Delta v$ | Input transition rise or fall rate | V _{CC} = 3.3 V ± 0.3 V | | 10 | ns/V | |
| | | $V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$ | | 5 | | |
| T _A | Operating free-air temperature | · · · · | -40 | 125 | °C | |

 All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. See Implications of Slow or Floating CMOS Inputs, SCBA004.

6.4 Thermal Information

| | THERMAL METRIC ⁽¹⁾ | DBV (SOT-23) | DCK (SC70) | DRL (SOT) | YZP (DSBGA) | UNIT |
|----------------------|---|--------------|------------|-----------|-------------|------|
| | | 5 PINS | 5 PINS | 5 PINS | 5 PINS | |
| R_{\thetaJA} | Junction-to-ambient thermal resistance | 247.2 | 277.6 | 294.3 | 144.4 | °C/W |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance | 154.5 | 179.5 | 129.9 | 1.3 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 86.8 | 75.9 | 143.4 | 39.9 | °C/W |
| ΨJT | Junction-to-top characterization parameter | 58.0 | 49.7 | 14.3 | 0.5 | °C/W |
| ΨЈВ | Junction-to-board characterization parameter | 86.4 | 75.1 | 144.0 | 39.7 | °C/W |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

| | | | T _A = -40°C to +85°C | T _A = -40°C to +125°C | LINUT |
|------------------|---|-----------------|---------------------------------|----------------------------------|-------|
| PARAMETER | TEST CONDITIONS | V _{cc} | MIN TYP ⁽¹⁾ MAX | MIN TYP ⁽¹⁾ MAX | UNIT |
| | I _{OH} = -100 μA | 1.65 V to 5.5 V | V _{CC} – 0.1 | V _{CC} - 0.1 | |
| | $I_{OH} = -4 \text{ mA}$ | 1.65 V | 1.2 | 1.2 | |
| M | $I_{OH} = -8 \text{ mA}$ | 2.3 V | 1.9 | 1.9 | v |
| V _{OH} | I _{OH} = -16 mA | 3 V | 2.4 | 2.4 | v |
| | $I_{OH} = -24 \text{ mA}$ | 3 V | 2.3 | 2.3 | |
| | I _{OH} = -32 mA | 4.5 V | 3.8 | 3.8 | |
| | I _{OL} = 100 μA | 1.65 V to 5.5 V | 0.1 | 0.1 | |
| | I _{OL} = 4 mA | 1.65 V | 0.45 | 0.45 | |
| M | I _{OL} = 8 mA | 2.3 V | 0.3 | 0.3 | v |
| V _{OL} | I _{OL} = 16 mA | 2)/ | 0.4 | 0.4 | |
| | I _{OL} = 24 mA | 3 V | 0.55 | 0.55 | |
| | I _{OL} = 32 mA | 4.5 V | 0.55 | 0.55 | |
| II All inputs | V _I = 5.5 V or GND | 0 to 5.5 V | ±10 | ±5 | μA |
| l _{off} | $V_1 \text{ or } V_0 = 5.5 \text{ V}$ | 0 | ±10 | ±10 | μA |
| I _{CC} | $V_{\rm I} = 5.5$ V or GND, $I_{\rm O} = 0$ | 1.65 V to 5.5 V | 10 | 10 | μA |
| Δl _{CC} | One input at V_{CC} – 0.6 V, Other inputs at V_{CC} or GND | 3 V to 5.5 V | 500 | 500 | μA |
| Ci | $V_I = V_{CC}$ or GND | 3.3 V | 4 | 4 | pF |

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

6.6 Timing Requirements: $T_A = -40^{\circ}C$ to $+85^{\circ}C$

over operating free-air temperature range (unless otherwise noted) (see Figure 3)

| | | | | | T _A = -40°C to +85°C | | | | | | | | |
|--------------------|------------------------------------|-----------|-----|--|---------------------------------|------------|----------------------------------|-----|------------------------------------|-----|----------------------------------|--|------|
| PARAMETER | | PARAMETER | | ARAMETER V _{CC} = 1.8 ± 0.15 V | | 1.8 5 V | V _{CC} = 2.5 ± 0.2 V | | V _{CC} = 3.3 V ± 0.3 V | | V _{CC} = 5 V ± 0.5 V | | UNIT |
| | | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | | | |
| f _{clock} | lock Clock frequency | | | 160 | | 160 | | 160 | | 160 | MHz | | |
| tw | Pulse duration, CLK high or low | | 2.5 | | 2.5 | | 2.5 | | 2.5 | | ns | | |
| | Satur time before CLKA | Data high | 2.2 | | 1.4 | | 1.3 | | 1.2 | | | | |
| t _{su} | Setup time before CLK [↑] | Data low | 2.6 | | 1.4 | | 1.3 | | 1.2 | | ns | | |
| t _h | Hold time, data after CLK↑ | | 0.3 | | 0.4 | | 1 | | 0.5 | | ns | | |

6.7 Timing Requirements: $T_A = -40^{\circ}C$ to $+125^{\circ}C$

over operating free-air temperature range (unless otherwise noted) (see Figure 3)

| | | | | T _A = -40°C to +125°C | | | | | | | |
|--------------------|---------------------------------|-----------|-----|-----------------------------------|-----|----------------------------------|-----|-----------|----------------------------------|-----|------|
| PARAMETER | | PARAMETER | | V _{CC} = 1.8 ± 0.15 V | | V _{CC} = 2.5 ± 0.2 V | | .3 V V | V _{CC} = 5 V ± 0.5 V | | UNIT |
| | | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | |
| f _{clock} | Clock frequency | | | 160 | | 160 | | 160 | | 160 | MHz |
| t _w | Pulse duration, CLK high or low | | 2.5 | | 2.5 | | 2.5 | | 2.5 | | ns |
| | Satur time before CLKA | Data high | 2.2 | | 1.4 | | 1.3 | | 1.2 | | |
| t _{su} | Setup time before CLK↑ | Data low | 2.6 | | 1.4 | | 1.3 | | 1.2 | | ns |
| t _h | Hold time, data after CLK↑ | | 0.3 | | 0.4 | | 1 | | 0.5 | | ns |



6.8 Switching Characteristics: $C_L = 15 \text{ pF}$, $T_A = -40^{\circ}\text{C}$ to +85°C

<u>over recommended operating free-air temperature range</u>, $C_L = 15 \text{ pF}$ (unless otherwise noted) (see Figure 3)

| | | то (оитрит) | T _A = -40°C to +85°C | | | | | | | | |
|------------------|-----------------|----------------|-------------------------------------|-----|------------------------------------|-----|------------------------------------|-----|----------------------------------|-----|------|
| PARAMETER | FROM (INPUT) | | V _{CC} = 1.8 V ± 0.15 V | | V _{CC} = 2.5 V ± 0.2 V | | V _{CC} = 3.3 V ± 0.3 V | | V _{CC} = 5 V ± 0.5 V | | UNIT |
| | | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | |
| f _{max} | | | 160 | | 160 | | 160 | | 160 | | MHz |
| t _{pd} | CLK | Q | 2.5 | 9.1 | 1.2 | 6 | 1 | 4 | 0.8 | 3.8 | ns |

6.9 Switching Characteristics: $C_L = 30$ or 50 pF, $T_A = -40^{\circ}C$ to $+85^{\circ}C$

over recommended operating free-air temperature range, C_L = 30 pF or 50 pF (unless otherwise noted) (see Figure 4)

| | PARAMETER | | | | | T _A | = -40°C | C to +85° | С | | | |
|--|------------------|-----------------|----------------|-------------------------------------|-----|------------------------------------|---------|------------------------------------|-----|----------------------------------|-----|------|
| | | FROM (INPUT) | TO (OUTPUT) | V _{CC} = 1.8 V ± 0.15 V | | V _{CC} = 2.5 V ± 0.2 V | | V _{CC} = 3.3 V ± 0.3 V | | V _{CC} = 5 V ± 0.5 V | | UNIT |
| | | | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | |
| | f _{max} | | | 160 | | 160 | | 160 | | 160 | | MHz |
| | t _{pd} | CLK | Q | 3.9 | 9.9 | 2 | 7 | 1.7 | 5 | 1 | 4.5 | ns |

6.10 Switching Characteristics: $C_L = 30 \text{ pF}$ or 50 pF, $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$

over recommended operating free-air temperature range, C_L = 30 pF or 50 pF (unless otherwise noted) (see Figure 4)

| | | | T _A = -40°C to +125°C | | | | | | | | |
|------------------|-----------------|----------------|----------------------------------|-----|-----|-----|-----|-----|----------------------------------|-----|------|
| PARAMETER | FROM (INPUT) | TO (OUTPUT) | | | | | | | V _{CC} = 5 V ± 0.5 V | | UNIT |
| | | | MIN | MAX | MIN | MAX | MIN | MAX | MIN | MAX | |
| f _{max} | | | 160 | | 160 | | 160 | | 160 | | MHz |
| t _{pd} | CLK | Q | 3.9 | 12 | 2 | 8.5 | 1.7 | 6 | 1 | 5 | ns |

6.11 Operating Characteristics

 $T_A = 25^{\circ}C$

| | DADAMETED | ARAMETER TEST | | | V _{CC} = 3.3 V | $V_{CC} = 5 V$ | UNIT | |
|-----------------|-------------------------------|---------------|-----|-----|-------------------------|----------------|------|--|
| | FARAMETER | CONDITIONS | TYP | TYP | TYP | TYP | UNIT | |
| C _{pd} | Power dissipation capacitance | f = 10 MHz | 26 | 26 | 27 | 30 | pF | |

SN74LVC1G79

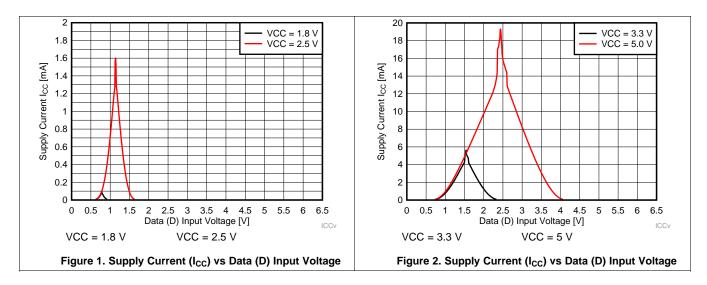
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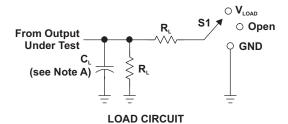
6.12 Typical Characteristics

This plot shows the different I_{CC} values for various voltages on the data input (D). Voltage sweep on the input is from 0 V to 6.5 V.



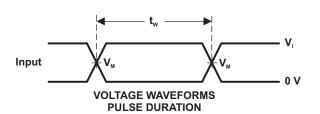


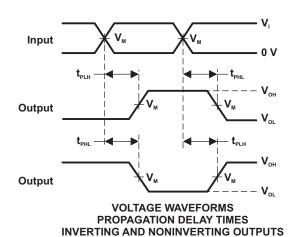
Parameter Measurement Information 7

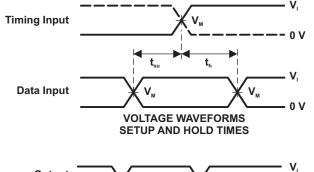


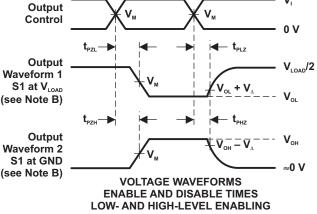
| TEST | S1 |
|------------------------------------|------------|
| t _{PLH} /t _{PHL} | Open |
| t_{PLZ}/t_{PZL} | V_{load} |
| t _{PHZ} /t _{PZH} | GND |

| N | INPUTS | | N N | N | • | _ | |
|-------------------|-----------------|---------|--------------------|---------------------|-------|--------------|--------|
| V _{cc} | V | t,/t, | V _M | V_{load} | C | R | V |
| 1.8 V ± 0.15 V | V _{cc} | ≤2 ns | V _{cc} /2 | 2 × V _{cc} | 15 pF | 1 Μ Ω | 0.15 V |
| $2.5 V \pm 0.2 V$ | V _{cc} | ≤2 ns | V _{cc} /2 | 2 × V _{cc} | 15 pF | 1 Μ Ω | 0.15 V |
| $3.3 V \pm 0.3 V$ | 3 V | ≤2.5 ns | 1.5 V | 6 V | 15 pF | 1 Μ Ω | 0.3 V |
| $5~V~\pm~0.5~V$ | V _{cc} | ≤2.5 ns | V _{cc} /2 | 2 × V _{cc} | 15 pF | 1 Μ Ω | 0.3 V |





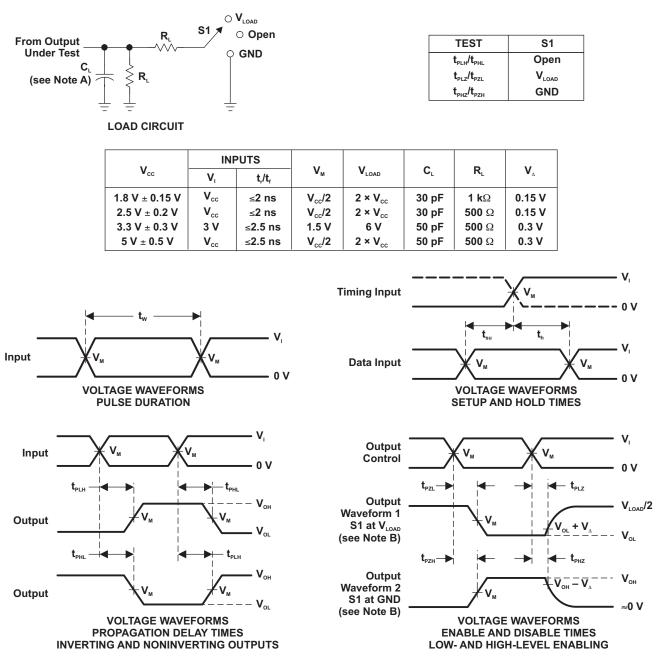




NOTES: A. C, includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_o = 50 Ω .
- D. The outputs are measured one at a time, with one transition per measurement.
- E. $t_{\mbox{\tiny PLZ}}$ and $\dot{t}_{\mbox{\tiny PHZ}}$ are the same as $t_{\mbox{\tiny dis}}$
- F. $t_{\mbox{\tiny PZL}}$ and $t_{\mbox{\tiny PZH}}$ are the same as $t_{\mbox{\tiny en}}.$
- G. $t_{Pl\,H}$ and t_{PHl} are the same as t_{rd} .
- H. All parameters and waveforms are not applicable to all devices.

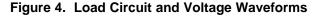
Figure 3. Load Circuit and Voltage Waveforms



Parameter Measurement Information (continued)

NOTES: A. C_{L} includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z₀ = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and \dot{t}_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. $t_{\mbox{\tiny PLH}}$ and $t_{\mbox{\tiny PHL}}$ are the same as $t_{\mbox{\tiny pd}}$
- H. All parameters and waveforms are not applicable to all devices.



ISTRUMENTS

EXAS



8 Detailed Description

8.1 Overview

The SN74LVC1G79 is a single positive-edge-triggered D-type flip-flop. Data at the input (D) is transferred to the output (Q) on the positive-going edge of the clock pulse when the setup time requirement is met. Because the clock triggering occurs at a voltage level, it is not directly related to the rise time of the clock pulse. This allows for data at the input to be changed without affecting the level at the output, following the hold-time interval.

8.2 Functional Block Diagram

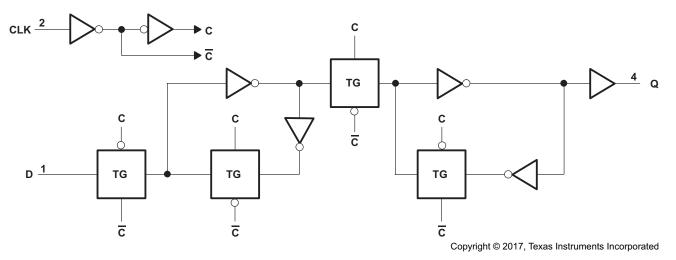


Figure 5. Logic Diagram (Positive Logic)

8.3 Feature Description

8.3.1 Balanced High-Drive CMOS Push-Pull Outputs

A balanced output allows the device to sink and source similar currents. The high drive capability of this device creates fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the power output of the device to be limited to avoid thermal runaway and damage due to over-current. The electrical and thermal limits defined the in the *Absolute Maximum Ratings* must be followed at all times.

8.3.2 Standard CMOS Inputs

Standard CMOS inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Recommended Operating Conditions*, and the maximum input leakage current, given in the *Electrical Characteristics*, using ohm's law ($R = V \div I$).

Signals applied to the inputs need to have fast edge rates, as defined by $\Delta t/\Delta v$ in *Recommended Operating Conditions* to avoid excessive currents and oscillations. If tolerance to a slow or noisy input signal is required, a device with a Schmitt-trigger input should be utilized to condition the input signal prior to the standard CMOS input.



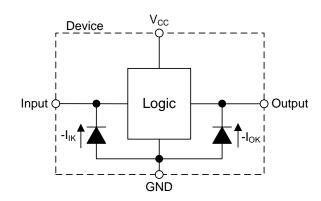
Feature Description (continued)

8.3.3 Clamp Diodes

The inputs and outputs to this device have negative clamping diodes.

CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input negative-voltage and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.





8.3.4 Partial Power Down (I_{off})

The inputs and outputs for this device enter a high impedance state when the supply voltage is 0 V. The maximum leakage into or out of any input or output pin on the device is specified by I_{off} in the *Electrical Characteristics*.

8.3.5 Over-Voltage Tolerant Inputs

Input signals to this device can be driven above the supply voltage so long as they remain below the maximum input voltage value specified in the *Absolute Maximum Ratings*.

8.4 Device Functional Modes

Table 1 lists the functional modes of SN74LVC1G79.

| INPL | OUTPUT | |
|------|--------|----------------|
| CLK | D | Y |
| ↑ | Н | Н |
| ↑ | L | L |
| L | Х | Q ₀ |

Table 1. Function Table



9 Application and Implementation

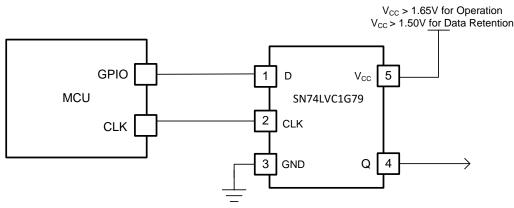
NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

A useful application for the SN74LVC1G79 is using it as a data latch with low-voltage data retention. This application implements the use of a microcontroller GPIO pin to act as a clock to set the output state and a second GPIO to provide the input data. If the SN74LVC1G79 is being powered from 1.8 V and there is concern that a power glitch could exist as low as 1.5 V, the device will retain the state of the Q output. An example of this data retention is shown in Figure 8 where the V_{CC} drops to 1.5 V and the Q output maintains the HIGH output state when V_{CC} returns to 1.8 V. If the V_{CC} voltage drops below 1.5 V, data retention is not guaranteed.

9.2 Typical Application



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Figure 7. Low Voltage Data Retention With SN74LVC1G79

9.2.1 Design Requirements

The SN74LVC1G79 device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits.

9.2.2 Detailed Design Procedure

- 1. Recommended input conditions:
 - For rise time and fall time specifications, see $\Delta t/\Delta v$ in *Recommended Operating Conditions*.
 - For specified high and low levels, see V_{IH} and V_{IL} in *Recommended Operating Conditions*.
 - Input voltages are recommended to not go below 0 V and not exceed 5.5 V for any V_{CC}. See *Recommended Operating Conditions*.
- 2. Recommended output conditions:
 - Load currents should not exceed ±50 mA. See Absolute Maximum Ratings.
 - Output voltages are recommended to not go below 0 V and not exceed the V_{CC} voltage. See Recommended Operating Conditions.



Typical Application (continued)

9.2.3 Application Curve

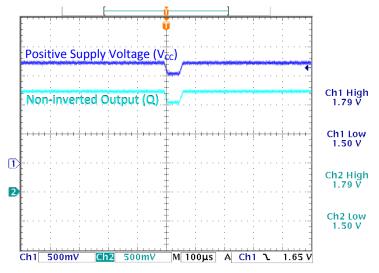


Figure 8. Data Retention With V_{CC} Glitch Down to 1.5 V

10 Power Supply Recommendations

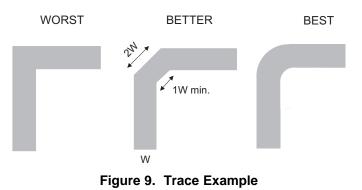
The power supply can be any voltage between the minimum and maximum supply voltage rating listed in *Recommended Operating Conditions*. A 0.1- μ F bypass capacitor is recommended to be connected from the VCC terminal to GND to prevent power disturbance. To reject different frequencies of noise, use multiple bypass capacitors in parallel. Capacitors with values of 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor must be installed as close to the power terminal as possible for best results.

11 Layout

11.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self–inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. Figure 9 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

11.2 Layout Example





12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

- Implications of Slow or Floating CMOS Inputs, SCBA004
- Understanding and Interpreting Standard Logic Data Sheets, SZZA036
- Power-Up Behavior of Clocked Devices, SCHA005

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Community Resources

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Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

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12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser based versions of this data sheet, refer to the left hand navigation.



4-May-2017

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish (6) | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|-------------------|---------------|--------------|--------------------|------|----------------|----------------------------|-------------------------|--------------------|--------------|-------------------------|---------|
| SN74LVC1G79DBVR | ACTIVE | SOT-23 | DBV | 5 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU CU SN | Level-1-260C-UNLIM | -40 to 125 | (C795 ~ C79F ~ C79R) | Samples |
| SN74LVC1G79DBVT | ACTIVE | SOT-23 | DBV | 5 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU CU SN | Level-1-260C-UNLIM | -40 to 125 | (C795 ~ C79F ~ C79R) | Samples |
| SN74LVC1G79DBVTG4 | ACTIVE | SOT-23 | DBV | 5 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | C79F | Samples |
| SN74LVC1G79DCKR | ACTIVE | SC70 | DCK | 5 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | (CR5 ~ CRF ~ CRR) | Samples |
| SN74LVC1G79DCKRE4 | ACTIVE | SC70 | DCK | 5 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | (CR5 ~ CRF ~ CRR) | Samples |
| SN74LVC1G79DCKRG4 | ACTIVE | SC70 | DCK | 5 | 3000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | (CR5 ~ CRF ~ CRR) | Samples |
| SN74LVC1G79DCKT | ACTIVE | SC70 | DCK | 5 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | (CR5 ~ CRF ~ CRR) | Samples |
| SN74LVC1G79DCKTG4 | ACTIVE | SC70 | DCK | 5 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | (CR5 ~ CRF ~ CRR) | Samples |
| SN74LVC1G79DRLR | ACTIVE | SOT-5X3 | DRL | 5 | 4000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -40 to 125 | (CR7 ~ CRR) | Samples |
| SN74LVC1G79YZPR | ACTIVE | DSBGA | YZP | 5 | 3000 | Green (RoHS & no Sb/Br) | SNAGCU | Level-1-260C-UNLIM | -40 to 85 | (CR7 ~ CRN) | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



4-May-2017

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74LVC1G79 :

- Automotive: SN74LVC1G79-Q1
- Enhanced Product: SN74LVC1G79-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | | | | | - | | - | | | - | | |
|-----------------------------|-----------------|--------------------|------|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| SN74LVC1G79DBVR | SOT-23 | DBV | 5 | 3000 | 180.0 | 8.4 | 3.23 | 3.17 | 1.37 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DBVR | SOT-23 | DBV | 5 | 3000 | 178.0 | 9.0 | 3.23 | 3.17 | 1.37 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DBVT | SOT-23 | DBV | 5 | 250 | 178.0 | 9.2 | 3.3 | 3.23 | 1.55 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DBVT | SOT-23 | DBV | 5 | 250 | 180.0 | 8.4 | 3.23 | 3.17 | 1.37 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DBVT | SOT-23 | DBV | 5 | 250 | 178.0 | 9.0 | 3.3 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DBVTG4 | SOT-23 | DBV | 5 | 250 | 178.0 | 9.0 | 3.23 | 3.17 | 1.37 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DCKR | SC70 | DCK | 5 | 3000 | 178.0 | 9.0 | 2.4 | 2.5 | 1.2 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DCKR | SC70 | DCK | 5 | 3000 | 178.0 | 9.2 | 2.4 | 2.4 | 1.22 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DCKR | SC70 | DCK | 5 | 3000 | 180.0 | 8.4 | 2.47 | 2.3 | 1.25 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DCKT | SC70 | DCK | 5 | 250 | 178.0 | 9.0 | 2.4 | 2.5 | 1.2 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DCKT | SC70 | DCK | 5 | 250 | 178.0 | 9.2 | 2.4 | 2.4 | 1.22 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DRLR | SOT-5X3 | DRL | 5 | 4000 | 180.0 | 8.4 | 1.98 | 1.78 | 0.69 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79DRLR | SOT-5X3 | DRL | 5 | 4000 | 180.0 | 9.5 | 1.78 | 1.78 | 0.69 | 4.0 | 8.0 | Q3 |
| SN74LVC1G79YZPR | DSBGA | YZP | 5 | 3000 | 178.0 | 9.2 | 1.02 | 1.52 | 0.63 | 4.0 | 8.0 | Q1 |

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PACKAGE MATERIALS INFORMATION

3-Aug-2017



| *All dimensions are nominal | | - | | | - | | - |
|-----------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| SN74LVC1G79DBVR | SOT-23 | DBV | 5 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74LVC1G79DBVR | SOT-23 | DBV | 5 | 3000 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DBVT | SOT-23 | DBV | 5 | 250 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DBVT | SOT-23 | DBV | 5 | 250 | 202.0 | 201.0 | 28.0 |
| SN74LVC1G79DBVT | SOT-23 | DBV | 5 | 250 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DBVTG4 | SOT-23 | DBV | 5 | 250 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DCKR | SC70 | DCK | 5 | 3000 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DCKR | SC70 | DCK | 5 | 3000 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DCKR | SC70 | DCK | 5 | 3000 | 202.0 | 201.0 | 28.0 |
| SN74LVC1G79DCKT | SC70 | DCK | 5 | 250 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DCKT | SC70 | DCK | 5 | 250 | 180.0 | 180.0 | 18.0 |
| SN74LVC1G79DRLR | SOT-5X3 | DRL | 5 | 4000 | 202.0 | 201.0 | 28.0 |
| SN74LVC1G79DRLR | SOT-5X3 | DRL | 5 | 4000 | 184.0 | 184.0 | 19.0 |
| SN74LVC1G79YZPR | DSBGA | YZP | 5 | 3000 | 220.0 | 220.0 | 35.0 |

YZP0005



PACKAGE OUTLINE

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



YZP0005

EXAMPLE BOARD LAYOUT

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).



YZP0005

EXAMPLE STENCIL DESIGN

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



DBV 5

GENERIC PACKAGE VIEW

SOT-23 - 1.45 mm max height SMALL OUTLINE TRANSISTOR



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



DBV0005A



PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 This drawing is subject to change without notice.
 Reference JEDEC MO-178.



DBV0005A

EXAMPLE BOARD LAYOUT

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

4. Publication IPC-7351 may have alternate designs.

5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DBV0005A

EXAMPLE STENCIL DESIGN

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

7. Board assembly site may have different recommendations for stencil design.



^{6.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

DRL (R-PDSO-N5)

PLASTIC SMALL OUTLINE



NOTES:

All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. Α. B. This drawing is subject to change without notice.

🖄 Body dimensions do not include mold flash, interlead flash, protrusions, or gate burrs. Mold flash, interlead flash, protrusions, or gate burrs shall not exceed 0,15 per end or side.





DRL (R-PDSO-N5)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
- E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
- F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.



DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES: A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-203 variation AA.



LAND PATTERN DATA



NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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